

Search Notes

Application/Control No.

09/669,854

Examiner

Quoc A. Tran

Applicant(s)/Patent under
Reexamination

IKEDA, IKUYO

Art Unit

2176

SEARCHED

Class	Subclass	Date	Examiner
715	764	7/9/2005	
358	1.15	7/9/2005	
345	629	7/9/2005	
Updated	Above	11/25/2005	

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
INVENTORS SEARCH CHECK FOR DOUBLE PATENT	7/9/2005	
EAST (US-PAT, US-PGPUB) see Search Histoty Printout	7/9/2005	
NPL IEEE DataBase see Search History Printout	7/9/2005	
Updated Above	11/25/2005	